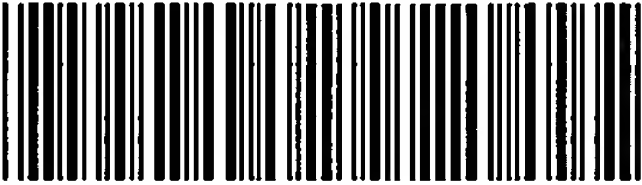


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,739	WEISS ET AL.	
	Examiner	Art Unit	
	Truc T. T. Nguyen	2833	

SEARCHED			
Class	Subclass	Date	Examiner
439	497 580-581	11/6/2005	TN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
439/497, 580-581 (US patent only)	11/6/2005	TN
text search (see search history print)	11/6/2005	tn